IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Priority Application Serial No
Priority Filing Date June 10, 2003
Inventor Leonard Forbes
Assignee Micron Technology, Inc.
Priority Group Art Unit
Priority Examiner
Attorney's Docket No MI22-2481
Title: Computer Systems, Processes For Turning A SRAM Cell Off, and Processes For
Writing A SRAM Cell and Processes for Reading Data Grown 4 SRAM Sef

INFORMATION DISCLOSURE STATEMENT PURSUANT TO 37 C.F.R. §§ 1.56, 1.97 AND 1.98

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

The listed references were cited by, or submitted to, the Office in the parent, co-pending application of the above-identified application. The above-identified application is a divisional application of co-pending application Serial No. 10/459,064, filed July 10, 2003. Such prior disclosure is sufficient for the above-identified application as far as copies of the references are concerned. 37 C.F.R. § 1.98(d) and MPEP § 609(2).

Citation of these references is respectfully requested.

Respectfully submitted,

Dated: 4 6 0 4

James D. Shaurette

By:

U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. PRIORITY SERIAL NO. Form PTO-1449 PATENT AND TRADEMARK OFFICE 10/459,064 LIST OF ART CITED BY APPLICANT APPLICANT Leonard Forbes (Use several sheets if necessary) PRIORITY FILING DATE PRIORITY GROUP July 10, 2003 2818 **U.S. PATENT DOCUMENTS** *Examiner Document Date Name Class Subclas Filing Date If Appropriate Initial Number 6,128,216 10/03/00 Noble, Jr. et al. AA AB 5,825,687 10/20/98 AC 6,287,913 B1 09/11/01 Agnello et al. ΑD 5,754,468 05/19/98 Hobson ΑE 6,104,045 08/15/00 Forbes et al. EL979949726 AF 6,225,165 B1 05/01/01 Noble, Jr. et al. 6,342,718 B1 01/29/02 Noble AG 6,194,759 B1 02/2001 AΗ Sano et al. 6,459,113 B1 10/01/02 Moribara et al. ΑI 2002/0028550 A1 03/07/02 Moribara et al. AK 6,011,726 01/04/00 Batson et al. FOREIGN PATENT DOCUMENTS Date Class Subclass Document Country Abstract Number Yes No 10-335488 12/1998 X AL Japan JP02001308298 A 11/02/01 AM Japan AN ΑO AΡ OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) AR Lage et al., "Advanced SRAM technology - the rate between 4T and 6T cells," Abstract (Web address - http://pluto.ei.org), Technical Digest - Proceedings of the 1996 IEEE International Electron Devices Meeting Dec. 8-11, 1996. AS Noda et al., "A 1.9-µm² Loadless CMOS Four-Transistor SRAM Cell in a 0.18-µm Logic Technology", 1998, ULSI Device Development Laboratories, NEC Corporation, Japan, 5 pages. ΑT DATE CONSIDERED **EXAMINER** *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include

copy of this form with next communication to applicant.

Sheet 2 of 2 Form PTO-1449 U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. PRIORITY SERIAL NO. PATENT AND TRADEMARK OFFICE MI22-2481 10/459,064 APPLICANT LIST OF ART CITED BY APPLICANT Leonard Forbes (Use several sheets if necessary) PRIORITY FILING DATE PRIORITY GROUP July 10, 2003 2818 U.S. PATENT DOCUMENTS Examiner Initial Document Date Name Class Subclass Filing Date Number If Appropriate AΑ 6,184,588 2/2001 Kim et al. ΑB 5,774,392 6/1998 Kraus et al. AC 6,212,102 4/2001 Georgakos et al. AD 6,265,266 7/2001 Dejenfelt et al. 2/1995 ΑE 5,388,068 Ghoshal et al. AF 5,754,010 5/1998 Caravella et al. E1.979949726 6,519,197 B2 2/11/2003 Forbes AG 2003/0076721 A1 4/24/2003 Forbes AH ΑI 6,275,433 B1 8/14/2001 Forbes 6,448,601 B1 9/10/2002 Forbes et al. 7/18/2000 AK 6,090,648 Reedy et al. FOREIGN PATENT DOCUMENTS Date Class Subclass Document Country **Abstract** Number Yes No ΑL AM ΑN AO AP OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) AR AS

EXAMINER DATE CONSIDERED

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